## **SFB 608**

## **Einladung zum Kolloquium**

Ort:	Universität zu Köln II. Physikalisches Institut, Seminarraum 201
Zeit:	4. Oktober, 2006, 14:30 Uhr
Sprecher:	Prof. S. Suga Graduate School of Engineering Science Osaka University, Japan <u>suga@mp.es.osaka-u.ac.jp</u>
Thema:	Three dimensional bulk sensitive ARPES by soft X- ray and high resolution hard X-ray PES of strongly

correlated electron systems

The surface sensitivity of conventional photoelectron spectroscopy (PES) is nowadays well recognized to hinder the probing of genuine bulk electronic structures in many cases of strongly correlated electron systems. Although the total energy resolution is limited by either low photoionization cross sections at high hv or limited resolution of photon monochromators, bulk sensitivity is quite essential to the study of strongly correlated electron systems.

I discuss 1) the potential of soft X-ray ARPES below 1keV to probe bulk band dispersions as well as 2) importance of the further bulk sensitivity by mean of hard X-ray PES (HAXPES) in the region of 3 to 8 keV for the study of 3d transition metal as well as 4f rare earth compound systems. The physics of the metal-to-insulator transition as well as the behavior of genuine bulk Kondo resonance are discussed.

Gez. Prof. H. Tjeng